# MOSFET – Power, Single, N-Channel, μ8FL 30 V, 52 A

#### **Features**

- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

#### **Applications**

- DC-DC Converters
- Power Load Switch
- Notebook Battery Management

#### MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise stated)

WAXIWOW NATINGS	, -	arnocc carorn			
Paran	neter		Symbol	Value	Unit
Drain-to-Source Voltage			$V_{DSS}$	30	V
Gate-to-Source Voltage			$V_{GS}$	±20	V
Continuous Drain		T <sub>A</sub> = 25°C	I <sub>D</sub>	15	Α
Current $R_{\theta JA}$ (Note 1)		T <sub>A</sub> = 85°C	1	10.8	
Power Dissipation $R_{\theta JA}$ (Note 1)		T <sub>A</sub> = 25°C	P <sub>D</sub>	2.13	W
Continuous Drain		T <sub>A</sub> = 25°C	I <sub>D</sub>	21	Α
Current $R_{\theta JA} \le 10 \text{ s}$ (Note 1)		T <sub>A</sub> = 85°C		15	
Power Dissipation $R_{\theta JA} \le 10 \text{ s (Note 1)}$	Steady	T <sub>A</sub> = 25°C	P <sub>D</sub>	4.2	W
Continuous Drain	-A		I <sub>D</sub>	9.3	Α
Current $R_{\theta JA}$ (Note 2)		T <sub>A</sub> = 85°C		6.7	
Power Dissipation R <sub>θJA</sub> (Note 2)		T <sub>A</sub> = 25°C	P <sub>D</sub>	0.82	W
Continuous Drain		T <sub>C</sub> = 25°C	I <sub>D</sub>	52	Α
Current R <sub>θJC</sub> (Note 1)		T <sub>C</sub> = 85°C	1	37.5	
Power Dissipation R <sub>θJC</sub> (Note 1)		T <sub>C</sub> = 25°C	P <sub>D</sub>	25.5	W
Pulsed Drain Current	T <sub>A</sub> = 25°0	C, t <sub>p</sub> = 10 μs	I <sub>DM</sub>	144	Α
Operating Junction and S	torage Ten	nperature	T <sub>J</sub> , T <sub>stg</sub>	-55 to +150	°C
Source Current (Body Die	I <sub>S</sub>	23	Α		
Drain to Source dV/dt	dV/dt	6.0	V/ns		
Single Pulse Drain–to–Source Avalanche Energy ( $T_J=25^{\circ}C$ , $V_{GS}=10$ V, $I_L=29A_{pk}$ , $L=0.1$ mH, $R_G=25\Omega$ ) (Note 3)			E <sub>AS</sub>	42	mJ
Lead Temperature for So (1/8" from case for 10 s)	Idering Pur	poses	TL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

- 1. Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.
- 2. Surface-mounted on FR4 board using the minimum recommended pad size.

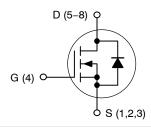


#### ON Semiconductor®

#### www.onsemi.com

V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub> MAX	I <sub>D</sub> MAX
30 V	5.9 mΩ @ 10 V	52 A
30 V	9.0 mΩ @ 4.5 V	32 A

#### **N-Channel MOSFET**





(μ8FL)

CASE 511AB

#### 

D

MARKING DIAGRAM

4C08 = Specific Device Code
A = Assembly Location
Y = Year
WW = Work Week

G [

= Pb-Free Package(Note: Microdot may be in either location)

#### ORDERING INFORMATION

Device	Package	Shipping <sup>†</sup>
NTTFS4C08NTAG	WDFN8 (Pb-Free)	1500 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

3. This is the absolute maximum ratings. Parts are 100% tested at  $T_J$  = 25°C,  $V_{GS} = 10 \text{ V}, I_L = 21 \text{ A}, E_{AS} = 22 \text{ mJ}.$ 

#### THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain)	$R_{ heta JC}$	4.9	
Junction-to-Ambient - Steady State (Note 4)	$R_{\theta JA}$	58.8	°C/W
Junction-to-Ambient - Steady State (Note 5)	$R_{\theta JA}$	153	*C/VV
Junction-to-Ambient - (t ≤ 10 s) (Note 4)	$R_{\theta JA}$	30	

- Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.
   Surface-mounted on FR4 board using the minimum recommended pad size.

#### **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		30			V
Drain-to-Source Breakdown Voltage (transient)	V <sub>(BR)DSSt</sub>	$V_{GS} = 0 \text{ V, } I_{D(aval)} = 12.6 \text{ A,}$ $T_{case} = 25^{\circ}\text{C, } t_{transient} = 100 \text{ ns}$		34			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /				13.8		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V,	T <sub>J</sub> = 25°C			1.0	
		V <sub>DS</sub> = 24 V				10	μΑ
Gate-to-Source Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> = 0 V, V <sub>GS</sub>	= ±20 V			±100	nA
ON CHARACTERISTICS (Note 6)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_D = 250 \mu A$		1.3		2.2	V
Negative Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				5.0		mV/°C
Drain-to-Source On Resistance	33 2	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 30 A		4.7	5.9	0
		I <sub>D</sub> = 18 A		7.2	9.0	mΩ	
Forward Transconductance	9 <sub>FS</sub>	V <sub>DS</sub> = 1.5 V, I <sub>D</sub> = 15 A			42		S
Gate Resistance	$R_{G}$	T <sub>A</sub> = 25°	С	0.3	1.0	2.0	Ω
CHARGES AND CAPACITANCES							
Input Capacitance	C <sub>ISS</sub>				1113		
Output Capacitance	C <sub>OSS</sub>	V <sub>GS</sub> = 0 V, f = 1 MH	z, V <sub>DS</sub> = 15 V		702		pF
Reverse Transfer Capacitance	C <sub>RSS</sub>				39		
Capacitance Ratio	C <sub>RSS</sub> /C <sub>ISS</sub>	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 15	V, f = 1 MHz		0.035		
Total Gate Charge	Q <sub>G(TOT)</sub>				8.4	15	
Threshold Gate Charge	Q <sub>G(TH)</sub>	V <sub>GS</sub> = 4.5 V, V <sub>DS</sub> = 15 V; I <sub>D</sub> = 30 A			1.8	3.5	
Gate-to-Source Charge	$Q_{GS}$				3.5	7.0	nC
Gate-to-Drain Charge	$Q_{GD}$				3.3	6.0	
Gate Plateau Voltage	V <sub>GP</sub>				3.4	7.0	V
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 1		18.2	35	nC	

#### **SWITCHING CHARACTERISTICS** (Note 7)

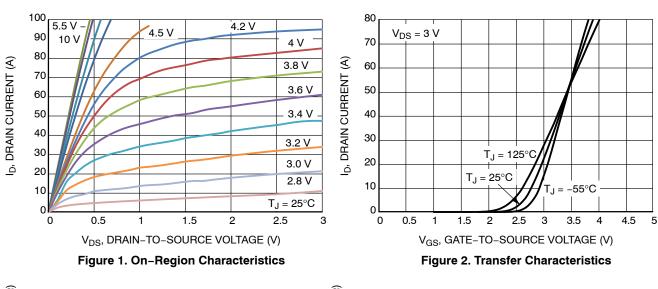
- 6. Pulse Test: pulse width  $\leq$  300  $\mu$ s, duty cycle  $\leq$  2%.
- 7. Switching characteristics are independent of operating junction temperatures.

### **ELECTRICAL CHARACTERISTICS** ( $T_J = 25^{\circ}C$ unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
SWITCHING CHARACTERISTICS (N	lote 7)				•	•	
Turn-On Delay Time	t <sub>d(ON)</sub>				9.0		
Rise Time	t <sub>r</sub>	$V_{GS} = 4.5 \text{ V}, V_{D}$	s = 15 V,		33		ns
Turn-Off Delay Time	t <sub>d(OFF)</sub>	$I_D = 15 A, R_G$	= 3.0 Ω		15		
Fall Time	t <sub>f</sub>				4.0		
Turn-On Delay Time	t <sub>d(ON)</sub>	$V_{GS}$ = 10 V, $V_{DS}$ = 15 V, $I_{D}$ = 15 A, $R_{G}$ = 3.0 $\Omega$			7.0		ns
Rise Time	t <sub>r</sub>				26		
Turn-Off Delay Time	t <sub>d(OFF)</sub>				19		
Fall Time	t <sub>f</sub>				3.0		
DRAIN-SOURCE DIODE CHARACT	ERISTICS						
Forward Diode Voltage	$V_{SD}$	$V_{GS} = 0 \text{ V},$ $I_{S} = 10 \text{ A}$ $T_{J} = 25^{\circ}\text{C}$ $T_{J} = 125^{\circ}\text{C}$			0.79	1.1	
					0.66		V
Reverse Recovery Time	t <sub>RR</sub>	$V_{GS}$ = 0 V, dIS/dt = 100 A/ $\mu$ s, I <sub>S</sub> = 30 A			28.3		
Charge Time	ta				14.5		ns
Discharge Time	t <sub>b</sub>				13.8		
Reverse Recovery Charge	Qpp			15.3		nC	

<sup>6.</sup> Pulse Test: pulse width  $\leq$  300  $\mu$ s, duty cycle  $\leq$  2%.
7. Switching characteristics are independent of operating junction temperatures.

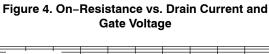
#### **TYPICAL CHARACTERISTICS**

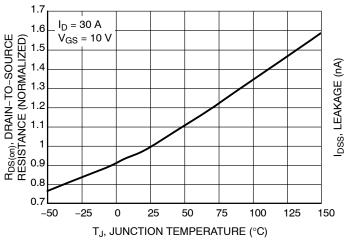


0.020 0.018 0.014 0.014 0.010 0.010 0.0006 0.0004 0.0004 0.0004 0.0004 0.0004 0.0004 0.0004 0.0004 0.0004 0.0004 0.0004 0.0005 0.00

 $\widetilde{\mathsf{R}_{\mathsf{DS}(\mathsf{on})}}$ , DRAIN-TO-SOURCE RESISTANCE  $(\Omega)$ 0.010 T<sub>J</sub> = 25°C 0.009 0.008  $V_{GS} = 4.5 \text{ V}$ 0.007 0.006  $V_{GS} = 10 V$ 0.005 0.004 0.003 0.002 50 20 30 40 60 10 70 ID, DRAIN CURRENT (A)

Figure 3. On–Resistance vs.  $V_{\text{GS}}$ 







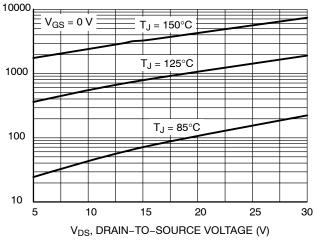


Figure 6. Drain-to-Source Leakage Current vs. Voltage

#### **TYPICAL CHARACTERISTICS**

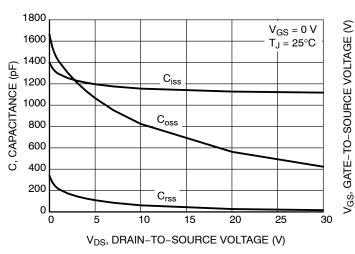


Figure 7. Capacitance Variation

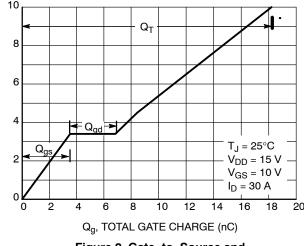


Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

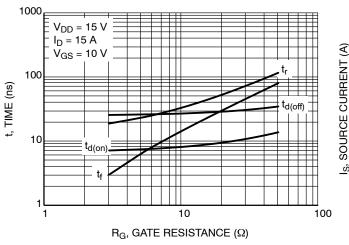


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

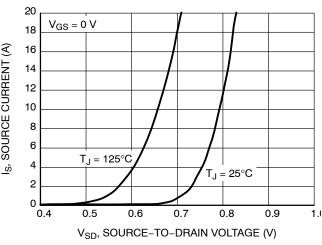


Figure 10. Diode Forward Voltage vs. Current

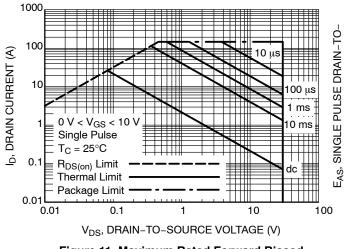


Figure 11. Maximum Rated Forward Biased Safe Operating Area

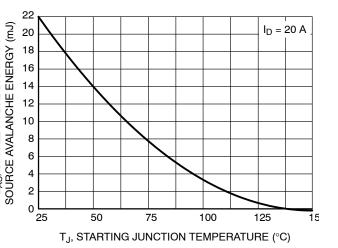


Figure 12. Maximum Avalanche Energy vs. Starting Junction Temperature

#### **TYPICAL CHARACTERISTICS**

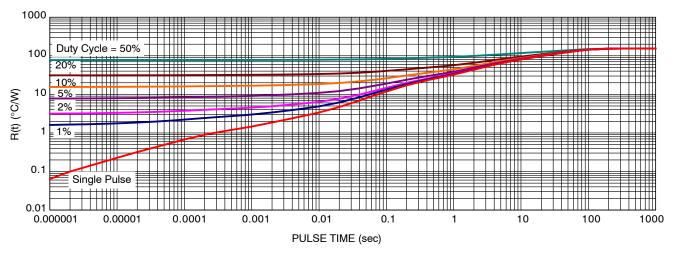


Figure 13. Thermal Response

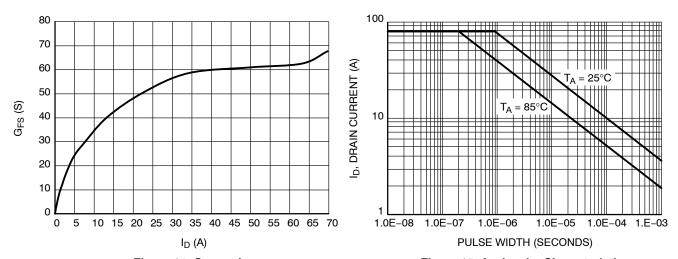


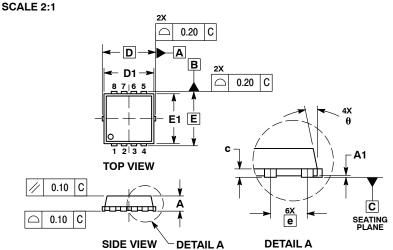
Figure 14.  $G_{FS}$  vs.  $I_D$ 

Figure 15. Avalanche Characteristics



#### WDFN8 3.3x3.3, 0.65P CASE 511AB ISSUE D

**DATE 23 APR 2012** 



#### NOTES:

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
  CONTROLLING DIMENSION: MILLIMETERS.
  DIMENSION D1 AND E1 DO NOT INCLUDE MOLD FLASH
  PROTRUSIONS OR GATE BURRS.

	MI	LLIMETE	RS		INCHES	
DIM	MIN	NOM	MAX	MIN	NOM	MAX
Α	0.70	0.75	0.80	0.028	0.030	0.031
A1	0.00		0.05	0.000		0.002
b	0.23	0.30	0.40	0.009	0.012	0.016
С	0.15	0.20	0.25	0.006	0.008	0.010
D		3.30 BSC		0	.130 BSC	;
D1	2.95	3.05	3.15	0.116	0.120	0.124
D2	1.98	2.11	2.24	0.078	0.083	0.088
E		3.30 BSC		0	.130 BSC	;
E1	2.95	3.05	3.15	0.116	0.120	0.124
E2	1.47	1.60	1.73	0.058	0.063	0.068
E3	0.23	0.30	0.40	0.009	0.012	0.016
е	0.65 BSC			(	0.026 BS	0
G	0.30	0.41	0.51	0.012	0.016	0.020
K	0.65	0.80	0.95	0.026	0.032	0.037
L	0.30	0.43	0.56	0.012	0.017	0.022
L1	0.06	0.13	0.20	0.002	0.005	0.008
М	1.40	1.50	1.60	0.055	0.059	0.063
θ	0 °		12 °	0 °		12 °



#### **GENERIC MARKING DIAGRAM\***

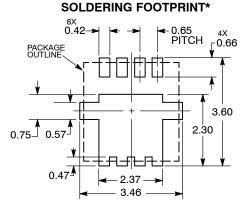


XXXXX = Specific Device Code = Assembly Location

= Year WW = Work Week = Pb-Free Package

\*This information is generic. Please refer to device data sheet for actual part marking.

Pb-Free indicator, "G" or microdot " ■", may or may not be present.



DIMENSION: MILLIMETERS

\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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DESCRIPTION:	WDFN8 3.3X3.3, 0.65P		PAGE 1 OF 1	

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